

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10551039	FUJITA ET AL.
Examiner	Art Unit	
NIKHIL SRIRAMAN	3664	

SEARCHED

Class	Subclass	Date	Examiner
700	245, 248, 249, 250, 253	12/20/2008	NS

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with Marc McDieunel	12/20/2008	
Assignee search on East, Inventor search on eDan		
NPL, including IEEE databases searched (see attached history)		

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner